	Application No.	Applicant(s)	
Notice of Allowability	10/040,061	LIN ET AL.	
	Examiner	Art Unit	
	Kevin M Bernatz	1773	
The MAILING DATE of this communication apperall claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this app or other appropriate communication GHTS. This application is subject to	olication. If not include will be mailed in due	ed course. THIS
1. This communication is responsive to <i>interview of 6/21/04</i> .			
2. The allowed claim(s) is/are 1-26 and 28.			
3. The drawings filed on 04 January 2002 are accepted by the	e Examiner.		
 4. ☐ Acknowledgment is made of a claim for foreign priority und a) ☐ All b) ☐ Some* c) ☐ None of the: 1. ☐ Certified copies of the priority documents have 2. ☐ Certified copies of the priority documents have 	been received.	·	
3. Copies of the certified copies of the priority documents have been received in this national stage application from the			
International Bureau (PCT Rule 17.2(a)).			
* Certified copies not received:			
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		complying with the rec	quirements
5. A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which give	itted. Note the attached EXAMINER' es reason(s) why the oath or declarate	S AMENDMENT or N tion is deficient.	OTICE OF
6. CORRECTED DRAWINGS (as "replacement sheets") mus	t be submitted.		
(a) ☐ including changes required by the Notice of Draftspers	on's Patent Drawing Review (PTO-9	948) attached	
1) 🗌 hereto or 2) 🔲 to Paper No./Mail Date			
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date	s Amendment / Comment or in the O	ffice action of	
Identifying indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in the			back) of
7. DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT I	sit of BIOLOGICAL MATERIAL m FOR THE DEPOSIT OF BIOLOGICA	nust be submitted. N AL MATERIAL.	lote the
Attachment(s)			
1. Notice of References Cited (PTO-892)	5. Notice of Informal Pa	• • • • • • • • • • • • • • • • • • • •	D-152)
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. ⊠ Interview Summary (Paper No./Mail Date	*	
 Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date 			
4. ☐ Examiner's Comment Regarding Requirement for Deposit	8. X Examiner's Stateme	nt of Reasons for Allo	wance
of Biological Material	9.		

Examiner's Amendment

1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

2. Authorization for this examiner's amendment was given in a telephone interview with Mr. David McKenzie on June 23, 2004.

The application has been amended as follows:

- Claim 1, line 5: a ";" was inserted after "material";
- Claim 1, line 6: "a" was inserted before the first occurrence of "pinning" and the first occurrence of "layers" was changed to "layer";
- Claim 1, line 7: the second occurrence of "layers" was replaced with "layer having a thickness of at least about 200 Å and"; and
- Claim 1, line 7: after "Ni-Mn films", the phrase "each having a Mn content in the range of about 40 at% and 60 at%" was inserted,
- Claim 14, line 6: "a" was inserted before the first occurrence of "pinning" and the first occurrence of "layers" was changed to "layer";
- Claim 14, line 7: the second occurrence of "layers" was replaced with "layer having a thickness of at least about 200 Å and"; and
- Claim 14, line 7: after "Pt-Mn films", the phrase "each having a Mn content in the range of about 40 at% and 60 at%" was inserted.
- Claim 25, line 2: "150" was replaced with "200";

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- Claim 27 was cancelled;
- Claim 28, line 7: "a" was inserted before the first occurrence of "pinning" and the first occurrence of "layers" was changed to "layer";
- Claim 28, line 8: the second occurrence of "layers" was replaced with "layer having a thickness of at least about 200 Å and";
- Claim 28, line 9: after "films", the phrase "each having a Mn content in the range of about 40 at% and 60 at%, the films" was inserted; and
- Claim 28, line 10: "Mn-based" was replaced with "Ni-Mn or Pt-Mn".

Oath/Declaration

3. The oath or declaration is defective. A new oath or declaration in compliance with 37 CFR 1.67(a) identifying this application by application number and filing date is required. See MPEP §§ 602.01 and 602.02.

The oath or declaration is defective because:

Non-initialed and/or non-dated alterations have been made to the oath or declaration. See 37 CFR 1.52(c). Specifically, the change in the address for Daniele Mauri.

Reasons for Allowance

4. The present claims are deemed allowable over JP '919 A since JP '919 A fails to disclose or render obvious the unexpected results achieved when forming a spin-valve sensor comprising a pinning layer comprising at least two AFM films selected from the same binary Ni-Mn or Pt-Mn alloy system, wherein the at least two AFM films each have

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an Mn content in the range of about 40 to about 60 at% and the entire pinning layer has a thickness of at least about 200 Å.

While JP '919 A disclose a pinning layer comprising at least two AFM films selected from various Mn-based alloys, including embodiments wherein both films are Ni-Mn or Pt-Mn, JP '919 A fail to disclose pinning layers meeting applicants' claimed thickness limitations and further fails to recognize the unexpected improvements shown by applicants' in their as-filed disclosure and the declaration submitted by Mr Lin when using at least two AFM films selected from the same binary Ni-Mn or Pt-Mn alloy system, wherein both films possess a Mn content of 40 – 60 at%.

5. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Kevin M Bernatz whose telephone number is (571) 272-1505. The examiner can normally be reached on M-F, 9:00 AM - 6:00 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Paul Thibodeau can be reached on (571) 272-1516. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Kevin M. Bernatz, PhD Primary Examiner

June 25, 2004